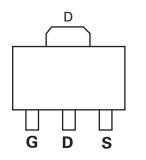
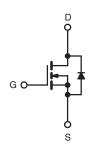


# N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ )	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
30	0.028 at V <sub>GS</sub> = 10 V	6	3.8 nC				
30	0.034 at V <sub>GS</sub> = 4.5 V	6	3.6 110				





N-Channel MOSFET

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested

## **APPLICATIONS**

- · System Power
  - Notebook
  - Netbook
- Load Switch
- Low Current DC/DC

ABSOLUTE MAXIMUM RATINGS	$T_A = 25  ^{\circ}C$ , unles	ss otherwise n	oted		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	$V_{DS}$	30	V		
Gate-Source Voltage	$V_{GS}$	± 20	v		
	T <sub>C</sub> = 25 °C		6 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l <sub>a</sub>	6 <sup>a</sup>		
Continuous Brain Guirent (1) = 130 O)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	6 <sup>a,b, c</sup>		
	T <sub>A</sub> = 70 °C		5.5 <sup>a,b, c</sup>	Α	
Pulsed Drain Current	Pulsed Drain Current				
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	l <sub>o</sub>	4.8		
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	1.9 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		5.7		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	3.6	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C		2.3 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		1.5 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ran	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature)		260			

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient	t ≤ 5 s	R <sub>thJA</sub>	45	55	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	18	22	O/ <b>VV</b>			

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.



ROHS COMPLIANT HALOGEN FREE



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				1			
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		35		\//0C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 4.5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1.0		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0 1 1/1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μΑ	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			5		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 10 V	20			Α	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.8 A		0.023	0.028	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 6.2 A		0.028	0.034		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 6.8 A		17		S	
Dynamic <sup>b</sup>	1 -10	25				l	
Input Capacitance	C <sub>iss</sub>			435			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		95		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			42			
T. 10 1 0	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 7.8 \text{ A}$		8	12	nC	
Total Gate Charge				3.8	6		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 7.8 \text{ A}$		1.4			
Gate-Drain Charge	$Q_{gd}$			1.1			
Gate Resistance	$R_{g}$	f = 1 MHz	1.5	3.2	4.5	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			15	25		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 2.4 $\Omega$		12	20	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 6.3$ A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		13	20		
Fall Time	t <sub>f</sub>			10	15		
Turn-On Delay Time	t <sub>d(on)</sub>			5	10		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 2.4 $\Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 6.3$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		15	25		
Fall Time	t <sub>f</sub>			10	15		
<b>Drain-Source Body Diode Characteristi</b>	cs			•			
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			4.2	^	
Pulse Diode Forward Current	I <sub>SM</sub>				30	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 6.3 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	25	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 6.3 A, dI/dt = 100 A/μs, T <sub>.1</sub> = 25 °C		7	12	nC	
Reverse Recovery Fall Time	ta	i <sub>F</sub> = 0.3 A, αί/αι = 100 A/μs, 1 <sub>J</sub> = 25 °C		9			
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		6		ns	

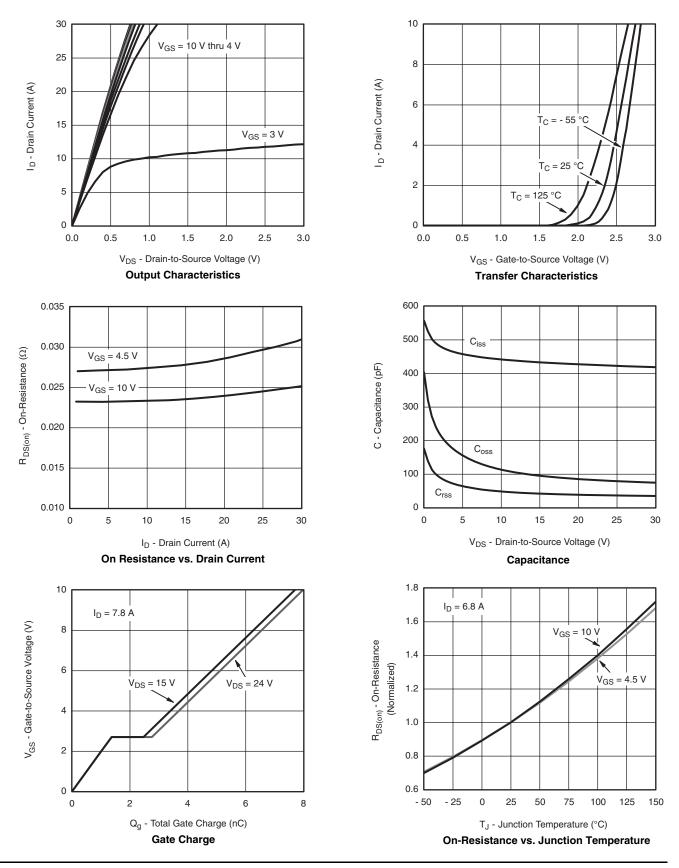
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

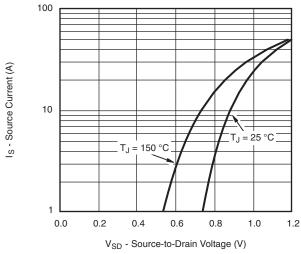


#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

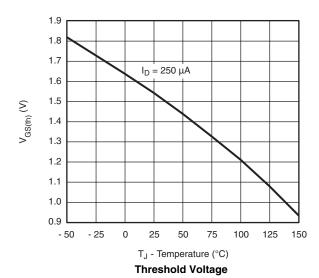


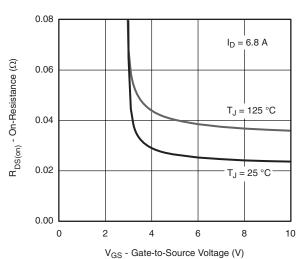


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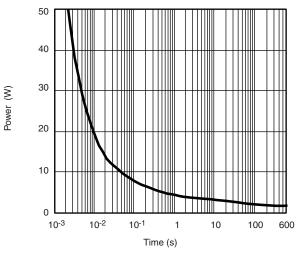


### Forward Diode Voltage vs. Temperature

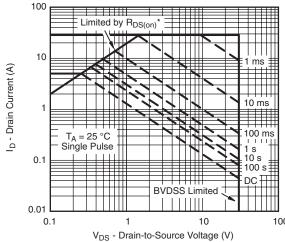




On-Resistance vs. Gate-Source Voltage



Single Pulse Power



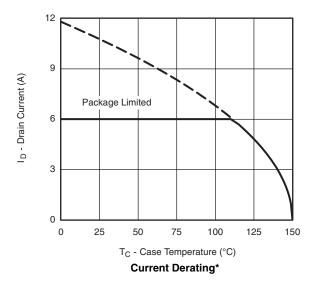
\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

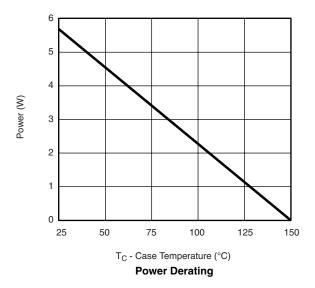
Safe Operating Area, Junction-to-Ambient



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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

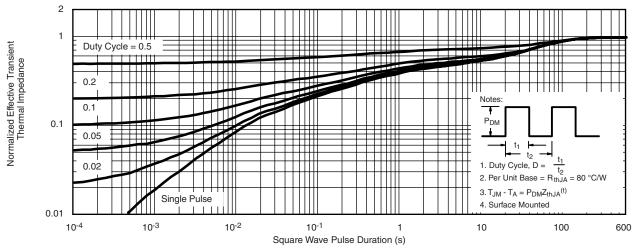




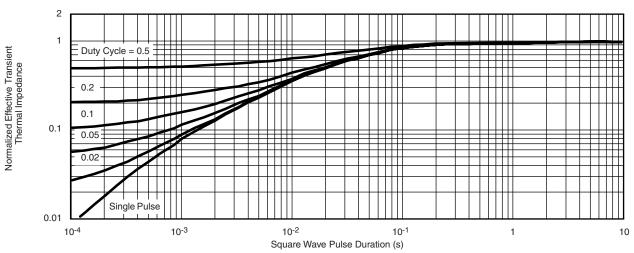
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



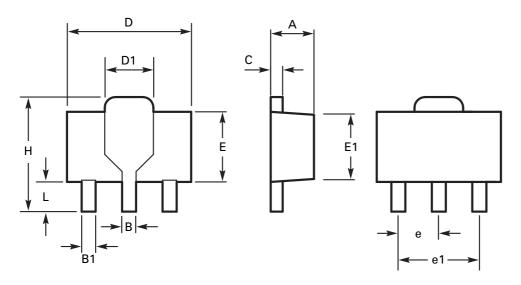
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



# Package outline - SOT89



DIM	Millin	Millimeters		Inches		Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	1.40	1.60	0.550	0.630	Е	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
С	0.35	0.44	0.014	0.017	e1	3.00 BSC		SC 0.118 BSC	
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.62	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches



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